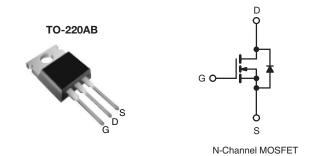


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
R _{DS(on)} (Ω)	V _{GS} = 10 V 3.0			
Q _g (Max.) (nC)	17			
Q _{gs} (nC)	4.3			
Q _{gd} (nC)	8.5			
Configuration	Single			



FEATURES

• Low Gate Charge Qq Results in Simple Drive



- Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half bridge
- Full bridge

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free	IRF820APbF			
Lead (FD)-11ee	SiHF820A-E3			
SnPb	IRF820A			
ט וווט	SiHF820A			

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V _{DS}	500			
Gate-Source Voltage		V_{GS}	± 30	- V	
Continuous Drain Current	V_{GS} at 10 V $\frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$	l-	2.5		
Continuous Drain Current	$T_C = 100 ^{\circ}C$	ID	1.6	Α	
Pulsed Drain Current ^a	I _{DM}	10	1		
Linear Derating Factor		0.40	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	140	mJ		
Repetitive Avalanche Current ^a	I _{AR}	2.5	А		
Repetitive Avalanche Energy ^a	E _{AR}	5.0	mJ		
Maximum Power Dissipation $T_C = 25 ^{\circ}C$		P _D	50	W	
Peak Diode Recovery dV/dtc	dV/dt	3.4	V/ns		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	_	300 ^d			
Maunting Tayous	6.20 or M2 corour		10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 45 mH, R_g = 25 Ω , I_{AS} = 2.5 A (see fig. 12). c. I_{SD} \leq 2.5 A, dI/dt \leq 270 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.

- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5		

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	' _{GS} , I _D = 250 μA	2.0	-	4.5	V
Gate-Source Leakage	I _{GSS}	V _G	V _{GS} = ± 30 V		-	± 100	nA
Zana Oata Valta aa Duain Oannant	I _{DSS}	$V_{DS} = 5$	V _{DS} = 500 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current		V _{DS} = 400 V, \	V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.5 A ^b	-	-	3.0	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 5$	0 V, I _D = 1.5 A ^b	1.4	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V	_{GS} = 0 V,	-	340	-	
Output Capacitance	C _{oss}	V _I	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		53	-	- - pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	2.7	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V; V _{DS} = 1.0 V, f = 1.0 MHz			490		
Output Capacitance	C _{oss}	V _{GS} = 0 V; V _{DS} = 400 V, f = 1.0 MHz			15		
Effective Output Capacitance	C _{oss} eff.	$V_{GS} = 0 \text{ V}; $	V _{GS} = 0 V; V _{DS} = 0 V to 400 V ^c		28		
Total Gate Charge	Qg			-	-	17	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 2.5 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b	-	-	4.3	
Gate-Drain Charge	Q _{gd}]	ooo ng. o ana ro	-	-	8.5	
Turn-On Delay Time	t _{d(on)}			-	8.1	-	
Rise Time	t _r	V _{DD} = 2 ¹	50 V, I _D = 2.5 A,	-	12	-	1
Turn-Off Delay Time	t _{d(off)}	$R_{g} = 21 \Omega$, $R_{D} = 97 \Omega$, see fig. 10^{b}		-	16	-	- ns -
Fall Time	t _f			-	13	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	1	2.5	A
Pulsed Diode Forward Current ^a	I _{SM}			i	ı	10	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S	_S = 2.5 A, V _{GS} = 0 V ^b	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 2.5 A, dI/dt = 100 A/μs ^b		-	330	500	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	760	1140	nC
Forward Turn-On Time	t _{on}	Intrinsic turn	-on time is negligible (turn	-on is do	minated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

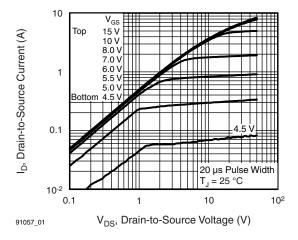


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

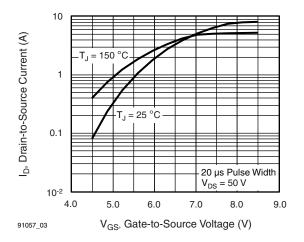


Fig. 3 - Typical Transfer Characteristics

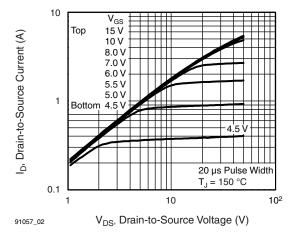


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

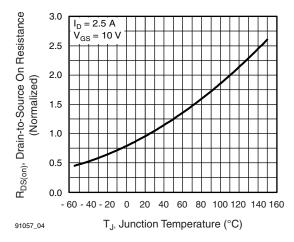


Fig. 4 - Normalized On-Resistance vs. Temperature



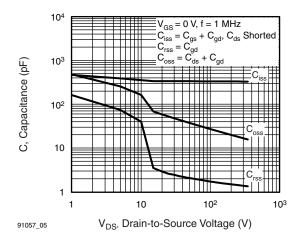


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

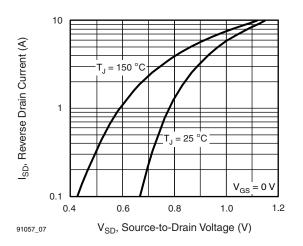


Fig. 7 - Typical Source-Drain Diode Forward Voltage

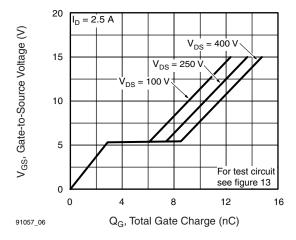


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

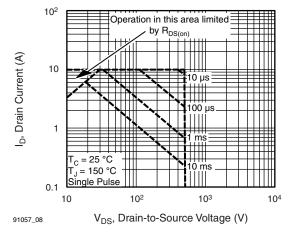


Fig. 8 - Maximum Safe Operating Area



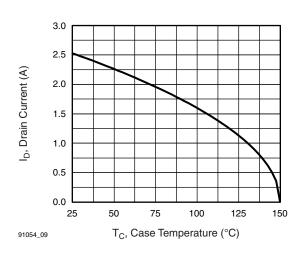


Fig. 9 - Maximum Drain Current vs. Case Temperature

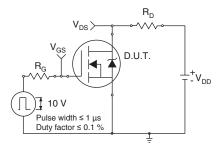


Fig. 10a - Switching Time Test Circuit

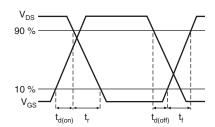


Fig. 10b - Switching Time Waveforms

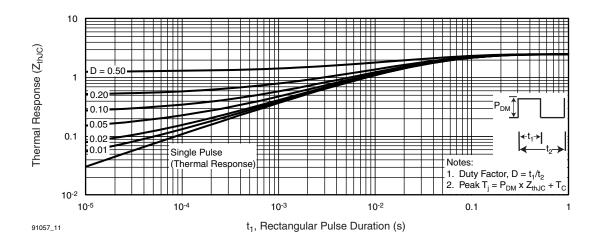


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



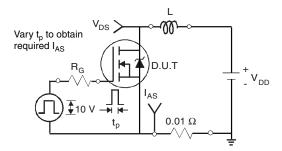


Fig. 12a - Unclamped Inductive Test Circuit

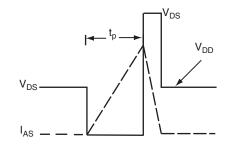


Fig. 12b - Unclamped Inductive Waveforms

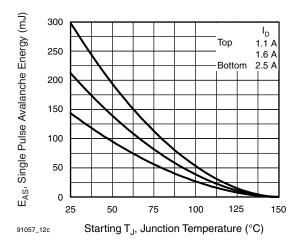


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

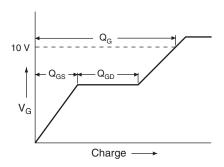


Fig. 12d - Basic Gate Charge Waveform

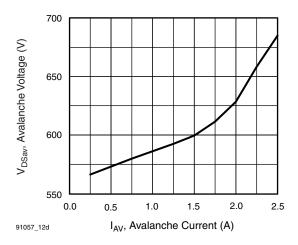


Fig. 13a - Typical Drain-to-Source Voltage vs.
Avalanche Current

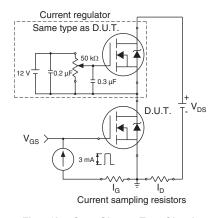
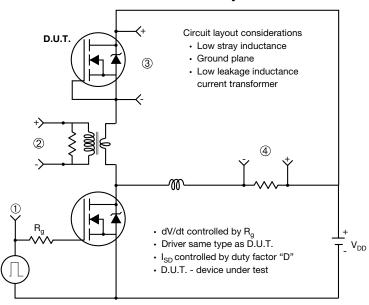


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



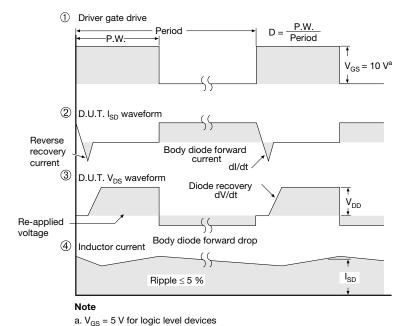
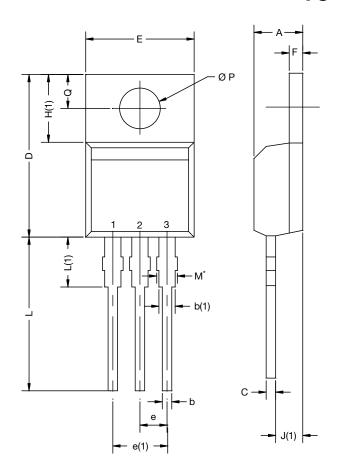


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91057.



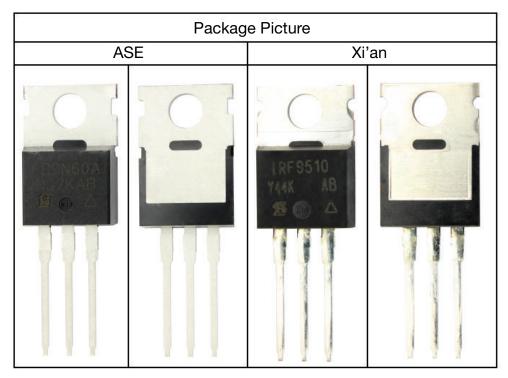
TO-220-1



DIM.	MILLIM	IETERS	INCHES		
DIIVI.	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
Е	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

单击下面可查看定价,库存,交付和生命周期等信息

>>Vishay(威世)